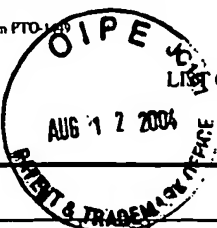


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Form PTO-159

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
M22-2467SERIAL NO.  
10757,253LIST OF ART CITED BY APPLICANT  
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2823

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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
Lee	AA	8,228,702 B1	05/01	Hirota			
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## FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
Lee	AM	US2004/ 006594	03/04	PCT - Search Report				
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Lee	AO	10 303412	11/98	JP - Abstract				
Lee	AP	2001 339081	12/01	JP - Abstract				
	AQ							

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AR		
	AS		
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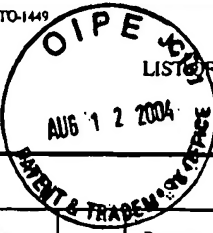

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DATE CONSIDERED

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2487		SERIAL NO. 10757,253	
				LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)			
				APPLICANT Denise M. Eppich et al. FILING DATE January 13, 2004 GROUP 2823			
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*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
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	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AM						
	AN						
	AO						
	AP						
	AQ						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
	AS						
	AT						
EXAMINER 		DATE CONSIDERED 10/27/2004					
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